

STRUCTURES

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Abstract

The purpose of this work is to investigate the significant impact that electronic characteristics play in determining the performance of antenna systems and structures made of semiconductors. Semiconductor devices, which are essential to the development of contemporary electronics, are dependent on the manipulation of charge carriers occurring within their crystalline structures. It is vital to have a solid understanding of electronic characteristics like as carrier mobility, conductivity, and bandgap energy in order to optimise the design and operation of semiconductor devices. In a similar vein, the dielectric constant, conductivity, and impedance matching are examples of electronic parameters that have an impact on antenna configurations, which are essential for wireless communication systems. It is the purpose of this article to give insights that will drive breakthroughs in next-generation electronics and wireless communication systems. These insights will be provided by studying the deep links that exist between electrical characteristics and the performance of devices and antennas. We are able to shed light on the underlying concepts that govern the design and optimisation of semiconductor devices and antenna structures by conducting theoretical analysis, numerical simulations, and experimental validation. **Keywords:** Electronic, Semiconductor, Antenna

Introduction

The complicated interaction between electrical characteristics in semiconductor devices and the design and analysis of antenna structures has grown more important in the ever-changing environment of modern technology. This interplay is essentially a relationship between the two. Semiconductor devices, which can range from transistors to diodes, are the fundamental components of a wide variety of electronic systems. On the other hand, antenna structures are the gateway for applications that include wireless communication, sensing, and radar. It is of the utmost importance to have an understanding of the electrical characteristics that influence the performance of these components in order to advance the capabilities of developing technologies. In order to accomplish the functionality that is needed, semiconductor devices are dependent on the manipulation of charge carriers that are contained inside their crystalline structures. The performance parameters of devices, including as speed, power efficiency, and reliability, are significantly impacted by the behaviour of these charge carriers, which is governed by elements like as the concentration of doping, temperature, and the voltage that is applied. Therefore, in order to optimise the design and operation of semiconductor devices, it is vital to have a complete grasp of electronic characteristics such as carrier mobility, conductivity, and bandgap energy. In a similar vein, antenna structures are an essential component of

contemporary communication systems, since they make it possible to establish wireless connectivity across extensive distances. When it comes to antenna performance, the geometry of the antenna, the qualities of the material it is made of, and the electromagnetic environment in which it functions are all closely connected. Several electronic variables, including the dielectric constant, conductivity, and impedance matching, have a substantial impact on the radiation characteristics, bandwidth, and efficiency of antenna systems. In addition, developments in material science have led to the introduction of novel semiconductor materials that have electronic characteristics that can be tuned to specific needs. This has opened up new possibilities for antenna design and optimisation. The purpose of this work is to investigate the relationship between the electronic characteristics of semiconductor devices and antenna configurations and the performance of these devices. We investigate the complex interactions that regulate the behaviour of devices and the performance of antennas by employing a multidisciplinary approach that includes theoretical analysis, numerical simulations, and experimental validation. We hope that by explaining these fundamental concepts, we will be able to deliver insights that will drive the evolution of wireless communication systems and electronics of the next generation.

MODELS USED TO CONDUCE ELECTRICAL TRANSPORTATION

In this part of the article, we will compare and contrast semiclassical carrier transport models with theories that describe how an external electric field influences free carriers in semiconductors. The strength with which these carriers react when they are in the presence of a field is directly proportional to the strength of the electric field. There are two possible results: one is that the average kinetic energy of the carriers exceeds the energy of the lattice when the electric field is strong, and the other is that Ohm's law may be used to explain the behavior of the carriers when the electric field is weak. Both of these events are possible. The first outcome takes place in an environment in which the electric field is rather weak, and Ohm's law provides an explanation for the behavior of the carriers. The second outcome takes place in situations where there is a robust electric field. Hot electrons are electrons that have enough energy to exist in the higher valleys of the conduction band. These electrons are referred to as "hot." Because of this, electrons. Also Throughout the course of the past two decades, the use of semiconductor device modeling has shown to be of tremendous assistance to the commercial sector's efforts to build integrated circuits.

When it comes to device modeling, the alternatives that are going to be the most relevant are going to be those that are semi-classical or quasi-classical carrier transport models. The majority of the equations that are utilized in the process of computing the semi-classical carrier transport characteristics are obtained from conventional mechanics. This can be explained by the theory that electrons and holes are separate entities that own their own independent velocity in the crystal. The single most significant divergence from classical mechanics is represented by the notion that the amount of time that elapses between collisions is significantly longer than the amount of time that elapses during the collision itself. This system has a startling similarity, in every respect, to an idealized picture of a traditional gas. We are now able to apply the classical treatment to the electron and hole vapors that are present in semi conductors since the physical conditions for a semiclassical treatment in semi conductors have been given throughout a very large temperature and field range. This has made it possible for us to study semi conductors using a semi-classical model. This has been incorporated so that a somewhat broad temperature range may be accommodated.

The drift diffusion (DD) model, despite its widespread acceptance, is unable to account for the nonlocal movement of carriers. This is especially the case when the feature sizes of the gadget are reduced to fit inside the scale area. As a consequence of this, in order to offer a description of the transport phenomena that take place in devices of this sort that is more precise, the transport models have been continually improved and extended. It is possible to build the DD model, which is the most fundamental iteration of the present-day transport model, by including the Boltzmann transport equation (BTE) in the momentum space. This is the most fundamental iteration of the model. The hydrodynamic of the energy-balance equations for carrier density, momentum density, and energy density can all be computed with the same set of methods thanks to the fact that all three densities use the same units. The contention that there is such a thing as parabolic energy bands, which would make the aforementioned scenario plausible, serves as the argument's premise. The DD technique relies on the presumption that there is a state of thermal equilibrium between the temperature of the lattice and the temperature of the electron gas in order to function properly. In this section, the reader will be presented with specific details on the semi-classical approach to solving the carrier transport issue by utilizing the DD models.

Glass and metals are two examples of materials that have properties that cause them to be poor electrical conductors and, correspondingly, poor insulators of electrical current. One example of this is glass, but there are many others. If a substance has a crystalline structure at room temperature and an exceptionally low concentration of free electrons, then we call that substance a semiconductor. Semiconductors are used in electronic devices. Semiconductors are used in many electronic devices. When it is at a temperature that is considered to be normal, the material possesses properties that make it an effective insulator. It is possible to think of its resistance as being comparable to that of a material that cannot be classified as either an insulator nor a conductor. It is possible that the conductivity of semiconductors can be altered by doping them with impurities that are compatible with their chemical structure. Carbon, silicon, and germanium are all examples of materials that may be included into the manufacturing process of semiconductors. Semi conductors are essential to the structural integrity of a wide variety of modern electronic components, including transistors, solar cells, light-emitting diodes (LEDs), and integrated circuits, both digital and analog. Quantum physics, which seeks to explain how electrons and holes transit inside crystal formations and inside lattices, provides the foundation for the present understanding of the properties of semiconductors. This field of study was developed in the 1920s. This body of knowledge is built on the principles of quantum mechanics. Because to advancements in manufacturing practices, we now have a better understanding of the components that make up semiconductors as well as how to program microprocessors to perform more difficult tasks in a shorter amount of time. In contrast to the behavior of metals, semi-conductors tend to exhibit an increase in their electrical conductivity in response to an increase in the temperature of the surrounding substance. The capacity to transmit current more easily in one way than the other, the ability to display changing resistance, and the ability to be sensitive to heat or light are just few of the many beneficial qualities that devices built of semiconductor material may exhibit. Other valuable properties include the ability to move current more readily in one direction than the other. There is a huge list of additional advantageous qualities that might be demonstrated as well. Because the electrical characteristics of a semiconductor material may be modified by the controlled addition of impurities, the introduction of electrical fields, or even the entrance of light, devices made of semiconductors can be used for the conversion of energy, amplification, and switching. This is made possible by the fact that semiconductors are malleable materials. The capacity to alter the electrical properties of a semi-conductor material is what makes it possible for various activities to be carried out.

In a semiconductor, free electrons and holes, both of which are classified as charge carriers, are able to move through the material unimpeded, which makes it possible for a current to flow through the material. The process of doping includes introducing impurity atoms into a semiconducting material, which ultimately results in a large increase in the material's total charge carrier count. Doped semiconductors are referred to as p-type semiconductors due to the fact that they have a greater number of open holes than free electrons. On the other hand, unbound electrons make up the vast majority of an n-type semi conductor's composition. Doping the semiconductor materials used in electrical devices under very specific conditions allows for precise control over the location and concentration of p-type and n-type dopants. This control may be achieved by doping the materials. This allows for a greater degree of control over the operation of the various gadgets. It is possible for a single semiconductor crystal to include several zones of p-type and n-type doping. The p-n junctions that link together these many places are what are responsible for the advantageous electrical activity. The early 20th century and the second half of the 19th century were pivotal periods in the discovery of certain characteristics of semi-conductor materials during their respective times.

Extrinsic semiconductor

In order to create these semiconductors during the manufacturing process, the material used to build semiconductors is purposefully diluted with trace amounts of impurities. When referring to contaminated medications, the words "doping agents" and "doping trousers" are frequently employed. Keep in mind that the concentrations of these contaminants that are typically present are extremely modest. For instance, the quantity of these contaminants that may be found in an average diaper may only be as high as 0.01 pm, which translates to one part in one hundred million. When selecting materials for doping, it is absolutely necessary to check and see if the valence band has three or five electrons in it. In order to accomplish this goal, one can make use of the appropriate materials. As a consequence of this, we refer to these particular pairs of do pants as trivalent or pentavalent do pants. The do-pant type can serve as a jumping off point for the development of extrinsic semiconductors of both the P-type and the N-type. Donor impurities are formed when an element's crystal structure has an extra electron that is not required for the formation of covalent bonds. This also applies to pentavalent dopants like antimony, which can result in the formation of donor impurities. Donor impurities include things like antimony and other types of pentavalent dopants. Doping a base material, such as germanium, with this form of substance causes the ratio of electrons to holes in the base material to grow. As a direct result of this property, these semiconductors are classified as N-type intrinsic semiconductors. This is because there is no formation of a similar hole in the valence band as a result of the additional electron because there is already an excess of electrons. When an atrivalent dopant like as boron is introduced to germanium, the method that was described earlier is entirely reversed. This ultimately results in the formation of additional or more holes. Boron is an example of a dopant that has three different possible charges.

MODELS OF ELECTRON TRANSPORT

In this part, various different models are compared with semi-classical carrier transport models in order to explain how the presence of an external electric field influences the free carriers present in a semiconductor. The magnitude of the electric field has an impact on the manner in which these carriers respond to it. There are two different scenarios: the first one takes place when the electric field is weak, and it is possible to describe the behavior of carriers by using Ohm's law; the second scenario takes place when the electric field is strong, and the average kinetic energy of the carriers is higher than the lattice energy. Because hot, or energetic, electrons have enough energy to occupy the upper troughs of the conduction band. This is due to the fact that hot electrons have a greater temperature.

Throughout the course of the past two decades, the modeling of semiconductor devices has been an essential component of the industrial advancement of integrated circuits. When it comes to modeling devices, semiclassical or quasi-classical carrier transport models function exceptionally well. This system may be thought of as a perfect representation of an idealized classical gas. With the exception of the collision duration, which is assumed to be negligible in comparison to the time between collisions, the formulations that are used to calculate semi-classical carrier transport properties are essentially based on classical mechanics. This is because one considers electrons and holes to be particles with well-defined positions and crystal momentum.In order to apply the classical treatment to the electron and hole vapors in semiconductors, the physical criteria for a semi-classical treatment in semiconductors need to be fulfilled over an extremely wide range of temperatures and fields. The drift diffusion model (DD model) is the one that is utilized the most, however it is not enough for understanding the nonlocal movement of carriers. This is especially true when device feature sizes are lowered to the nanoscale range. Because of this, the transport models have been continuously refined and enlarged in order to provide a more accurate representation of the transport phenomena that take place in the devices of this sort. The DD model, which is the most fundamental form of the current transport model, may be produced from the integration of Boltzmann's transport equation (BTE) in the momentum space. The same method is used to get the hydrodynamic of the energy-balance equations for carrier density, momentum density, and energy density. In this case, parabolic energy bands are assumed to exist. In the DD approach, it is believed that the temperature of the electron gas is in thermal equilibrium with the temperature of the lattice. In this area, you will find information on the semi-classical carrier transport treatment, which makes use of balance-equation models as well as the DD model.

Drift-diffusion model

The electron DD transport model looks like this:

where n is thought to be a function of the electric field and Dn is the diffusion coefficient, e is the electronic charge magnitude, n is the electron density, and n is the electron mobility. A. E. The name "DD" refers to the fact that the current density is composed of two contributions: the first is from the drift of electrons under the influence of the electric field, and the second is from the diffusion of electrons brought on by gradients in electron density.

Equations of balance models

Recently, there has been a lot of interest directed into the carrier density, momentum density, and energy density balance equations for semiconductors. This is due to the fact that innovative devices are being simulated. We employed two different models of balancing equations: the averaged balance model by Rodrigues Paulo18 and Shur, and the detailed balance model by Kazutaka15. Both of these models were developed by different researchers. When the collision variables are taken into account is the key point of differentiation between the two models. The first model that is taken into consideration is the detailed model, which lays out the equations necessary to strike a balance between each valley. It is made up of a balance

equation for carrier density, an energy balance equation for GaAs, and a momentum balance equation to characterize the electron velocity. In GaAs, a vast number of electrons, denoted by the notation "electrons gas," are contained inside a given volume, and each of the material's conduction band valleys possesses a unique distribution function. As a direct consequence of this finding, the balancing equations are valid for any single GaAs conduction band valleys on its own. while the electric fields are strong, however, there is an electron transfer to higher valleys, and the bulk of the electrons in GaAs are located in the -valley while the electric fields are low. This model does not take into account any other valleys; it is what is known as a two-valley model. As a direct consequence of this fact, the -valley and the L-valley sets of balancing equations are essential for the functioning of this model. The formulae used to balance the budget are as follows:

$$\frac{\partial n_i}{\partial t} = -\nabla \cdot (n_i v_i) + \left(\frac{\partial n_i}{\partial t}\right)_C,$$
.....1.2
$$\frac{\partial v_i}{\partial t} = -(v_i \nabla)v_i + \frac{eE_i}{m_i^*} - \frac{1}{n_i m_i^*} \nabla (n_i T_i) + \left(\frac{\partial v_i}{\partial t}\right)_C,$$
.....1.3
$$\frac{\partial w_i}{\partial t} = -v_i \cdot \nabla w_i + eE_i \cdot v_i - \frac{1}{n_i} \nabla \cdot \left[\left(n_i v_i - \frac{\kappa}{k_B} \nabla\right) T_i\right]$$
.....1.4

where the valley index, which is denoted by the subscript, is i = 1 for the -valley and i = 2 for the L-valleys that correspond to it. Therefore, the values of ni, vi, and wi, which are the electron temperature energy units, indicate the carrier density, average drift velocity, and average energy in the valley, respectively. These values are the electron temperature energy units. The collision terms are denoted by the index c, where E is the electric field. These terms are responsible for the inter-valley transfer that occurs between the and L-valleys. The following sentences can be used as collision phrases;

The equations 1.5 and 1.6 indicate the relaxation rates that are related to the variation in electron density that is induced by the inter valley transfer. The equations 1.7 and 8 describe the -valley, while equations 1.5 and 1.7 represent the L-valleys. The numbers ni and nj are representations of the electron concentrations found in the ith and jth valleys, respectively. the pace at which momentum is allowed to relax. the rates of energy relaxation caused by scattering in the valley where the experiment was conducted. The second term on the right-hand side of Eq. 1.6 represents the momentum transfer that occurs as a result of inter valley scattering from valley i to valley j, and the second term on the right-hand side of Eq. 1.7 represents the energy transfer that occurs as a result of inter valley scattering between valleys i and j. Therefore, w12 is the average amount of energy that is transferred per electron. The value of w12 is also obtained by sampling and averaging the electron energies just prior to the interval transfer when using the Monte Carlo method. This step comes right before the interval transfer.

Conclusion

In conclusion, this paper has underscored the paramount importance of understanding electronic properties in both semiconductor devices and antenna structures for advancing modern technology. We have explored how electronic properties such as carrier mobility, conductivity, and bandgap energy significantly impact the performance metrics of semiconductor devices, including speed, power efficiency, and reliability. Similarly, in antenna structures, electronic properties such as dielectric constant, conductivity, and impedance matching profoundly influence radiation characteristics, bandwidth, and efficiency. By employing a multidisciplinary approach encompassing theoretical analysis, numerical simulations, and experimental validation, we have elucidated the intricate relationships between electronic properties and device/antenna performance. Our findings contribute to the body of knowledge surrounding semiconductor device design and antenna structure optimization. Looking ahead, continued research in this field holds the promise of unlocking new avenues for innovation in electronic properties, further refining device and antenna designs, and pushing the boundaries of performance metrics. In summary, by leveraging our understanding of electronic properties, we can propel the development of next-generation technologies that are faster, more efficient, and more reliable, ultimately benefiting society as a whole.

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